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10/543,190 Examiner

TATEMATSU ET AL.

Applicant(s)/Patent under Reexamination

Art Unit

Huan H. Tran

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Class	Subclass	Date	Examiner
347	212,155 156	1/4/2007	ННТ
399	320,322	1/4/2007	ннт
399	323	1/4/2007	ННТ

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(347/212,155,156 or 399/320,322,323).ccls.	1/4/2007	ННТ
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